

Fundamental Theory of PMOS Low-Dropout Voltage Regulators

ABSTRACT

Most linear modern linear regulators use a PMOS architecture. This document covers the key characteristics of a PMOS LDO and the theory behind these linear regulators.

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Fundamentals	1
Regulator Sequence	4

List of Figures

1	Constant-Voltage Source	1
2	Output-Voltage Error vs Load Resistance	2
3	Linear Relation Between $R_{\mbox{\tiny IN}}$ and $R_{\mbox{\tiny LOAD}}$	2
4	Basic Linear-Voltage Regulator	3
5	PMOS Enhancement FET	4
6	Regulation Sequence When RLOAD Drops	5
7	Regulator Block Diagram	5
8	PMOS Input/Output Characteristic	6

List of Tables

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1 Fundamentals

A voltage regulator is a constant voltage source that adjusts its internal resistance to any occurring changes of load resistance to provide a constant voltage at the regulator output.

The internal resistance of a constant voltage source (Figure 1) must be significantly smaller than the external load resistor ($R_{IN} \ll R_{LOAD}$) to ensure a constant output voltage over a certain range of load changes.

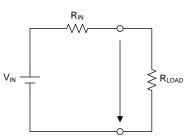


Figure 1. Constant-Voltage Source



Fundamentals

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The output voltage of a voltage source is calculated as Equation 1:

$$V_{OUT} = V_{IN} \times \frac{1}{1 + \frac{R_{IN}}{R_{LOAD}}}$$
(1)

Under a no-load condition ($R_{LOAD} = \infty$), the maximum output voltage possible is equal to the input voltage ($V_{OUT-MAX} = V_{IN}$). As the load increases, the output voltage drops from its maximum value and introduces an output-voltage error E_{VO} . This error E_{VO} is defined as the percentage difference between V_{OUT} under no-load condition ($V_{OUT-MAX}$), and V_{OUT} under load condition ($V_{OUT-LOAD}$), as described by Equation 2.

$$E_{VO} = \frac{V_{OUT-MAX} - V_{OUT-LOAD}}{V_{OUT-MAX}}$$
(2)

When replacing $V_{OUT-MAX}$ with V_{IN} and substituting $V_{OUT-LOAD}$ with the value in Equation 1, the voltage error is expressed through the resistor ratio of R_{IN} to R_{LOAD} , as given by Equation 3:

$$E_{VO} = \frac{R_{IN}}{R_{IN} + R_{LOAD}}$$
(3)

A plot of the voltage error over a series of R_{LOAD} -to- R_{IN} ratios confirms that the output voltage error E_{VO} increases with decreasing load resistance R_{LOAD} , as shown in Figure 2.

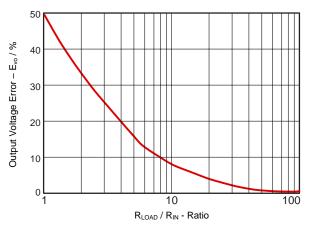


Figure 2. Output-Voltage Error vs Load Resistance

To minimize the error we need a circuit that senses any occurring load changes and, via some kind of feedback, adjusts a variable internal resistor to keep a constant ratio of internal-resistance to load-resistance, as described by Equation 4.

$$R_{IN} = R_{LOAD} \times k$$

(4)

When the relationship described in Equation 4 is true, R_{IN} then follows R_{LOAD} in a linear relation, as given by Equation 4. This circuit is shown in Figure 3.

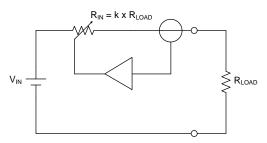


Figure 3. Linear Relation Between R_{IN} and R_{LOAD}

A circuit that achieves this relationship through adjusting the a variable resistor is basically a linear-voltage regulator, and is shown in Figure 4.

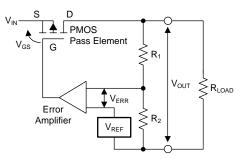


Figure 4. Basic Linear-Voltage Regulator

In the linear-voltage regulator shown in Figure 4, we can identify the building blocks discussed in the following sections.

1.1 Voltage Reference, V_{REF}

The voltage reference is the starting point of all regulators. This reference is usually a band-gap-type because this kind of reference has the ability to work down to low supply voltages, and provides enough accuracy and thermal stability to meet the less-stringent performance requirements of regulators. Band-gap references typically have an initial error of 0.5% to 1.0% and a temperature coefficient of 25 ppm/°C to 50 ppm/°C.

1.2 Error Amplifier

The error amplifier takes a scaled-down version of the output $[V_P = V_{OUT} R_1 / (R_1 + R_2)]$, compares it against the reference voltage ($V_P = V_{REF}$), and adjusts V_{OUT} via the series-pass element to the value required to drive the error signal ($V_{ERR} = V_P - V_{REF}$) as close as possible to zero. Setting $V_{REF} = V_P$ yields Equation 5:

$$V_{OUT} = V_{REF} \times \left(1 + \frac{R_1}{R_2}\right) \tag{5}$$

This calculation holds true only if V_{IN} is sufficiently high to keep the error amplifier and the pass element from saturating.

1.3 Feedback Network

The feedback network scales V_{OUT} to a value suitable for comparison against V_{REF} by the error amplifier. Because V_{REF} is fixed, the only way to program the value of V_{OUT} is by adjusting the ratio R_2 / R_1 .

1.4 Pass Element

The series-pass element boosts the output-current capabilities of the error amplifier to the higher levels required by the load. This process involves transferring large currents from the source V_{IN} to the load under the low-power supervision of the error amplifier. A suitable pass element to carry out this task is a PMOS enhancement FET. A PMOS FET has the two p-islands for the source and the drain terminals embedded in an n-substrate; see Figure 5a. The substrate is connected to the source, which usually has the most positive potential. The drain receives the most negative potential. As the PMOS name indicates, the device uses p-type conductivity, which is established by applying a voltage to the gate that is negative relative to the source. The holes, which are the minority carriers in the n-substrate, are attracted by the negative gate electrode. Moving towards the upper region between the two p-islands, the holes now become free-charge carriers, establishing a p-conductive bridge between source and drain. This way, the conductivity of the bridge, and with it the drain current ID, are controlled by the gate-source voltage, V_{GS} . Because this type of FET enhances its conductivity with increasing V_{GS} , it is called an enhancement or normally-off type (Figure 5b).



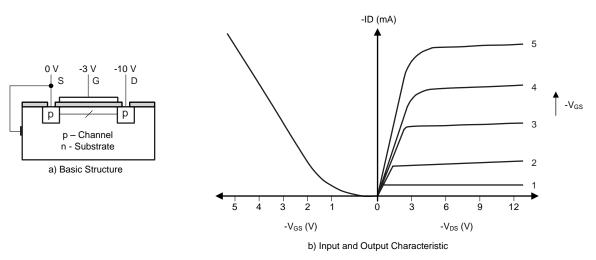


Figure 5. PMOS Enhancement FET

2 Regulator Sequence

This section describes the regulation sequence when R_{LOAD} drops as illustrated in Figure 6. Figure 7 depicts how the regulation sequence described relates to the internal LDO blocks.

When the load resistance drops, the output voltage falls from V_{OUT1} to V_{OUT2} , and the voltage across the pass element rises from $-V_{DS1}$ to $-V_{DS2}$. V_P (which is a scaled-down version of V_{OUT}) falls significantly below V_{REF} causing the gate-source voltage to jump from $-V_{GS1}$ to $-V_{GS2}$.

The PMOS FET now conducts harder, increasing the output current from I_{OUT1} to I_{OUT2} . The output voltage and, by virtue of V_P , the error voltage start to recover. The gate voltage increases gradually to $-V_{GS3}$, thus causing the increased output current I_{OUT3} to generate an output voltage V_{OUT} . When this output voltage is scaled down via R_1 and R_2 , the result is a zero-error voltage $V_{ERR} = 0$.

The output characteristic illustrated in Figure 8 confirms the regulation sequence. When R_{LOAD} drops, the PMOS FET operating point jumps from P_1 to P_2 and then regulates to P_3 .



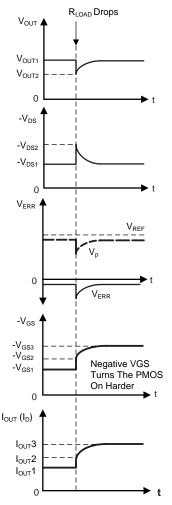


Figure 6. Regulation Sequence When RLOAD Drops

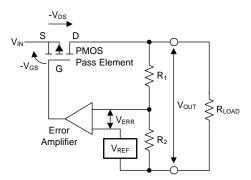


Figure 7. Regulator Block Diagram



(6)

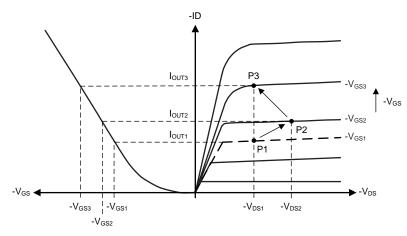


Figure 8. PMOS Input/Output Characteristic

For a given quiescent point P_N where the output voltage is stabilized (that is, V_{OUT} and V_{DS} are constant), we can define the internal resistance of the PMOS FET, and the load resistance in general terms as described in Equation 6:

$$R_{INN} = \frac{V_{DS}}{I_{OUTN}}$$

and

6

$$R_{LOAD} = \frac{V_{OUTN}}{I_{OUTN}}$$

Solving both equations for I_{OUT} yields:

$$I_{OUTN} = \frac{V_{DS}}{R_{INI}}$$

Solving for R_{IN} results in:

$$I_{OUTN} = R_{LOAD} \times \frac{V_{DS}}{V_{OUT}}$$

With $k = V_{DS}/V_{OUT}$, Equation 6 provides the linear relation required by a linear voltage regulator.



Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

CI	Changes from Original (April 1999) to A Revision	
•	Added Abstract section	. 1
•	Changed document format	. 1
•	Added text references for all figures and equations	. 1

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